# GP1S39J0000F

Gap: 1.5mm, Detector pitch: 1mm 2-phase Phototransistor Output, **Compact Transmissive Photointerrupter** 



#### Description

GP1S39J0000F is a compact-package, phototransistor output, transmissive photointerrupter, with opposing emitter and detector in a molding that provides noncontact sensing. The compact package series is a result of unique technology combing transfer and injection molding.

This is a 2-phase output device, suitable for detection of rotational/linear speed and direction.

#### Features

- 1. Transmissive with phototransistor output
- 2. Highlights :
  - Compact Size
  - · 2-phase output device
- 3. Key Parameters :
  - Gap Width : 1.5mm
  - · Detector pitch : 1mm (Detecting pitch : TYP. 0.6mm)
  - Package: 4.5×4×3.5mm
- 4. Lead free and RoHS directive compliant

#### Agency approvals/Compliance

1. Compliant with RoHS directive

#### Applications

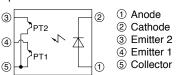
- 1. Detection of object presence or motion.
- 2. Example : printer, lens control for camera

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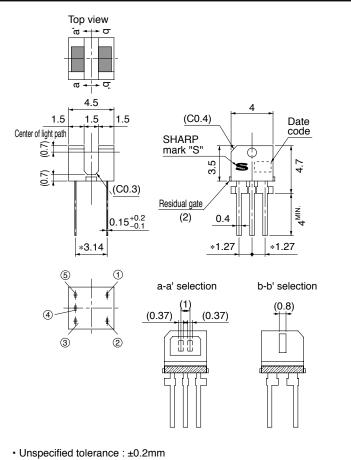
#### Internal Connection Diagram





(Unit : mm)

#### ■ Outline Dimensions



- Dimensions in parenthesis are shown for reference.
- The dimensions indicated by \*refer to those measured
- from the lead base. • The dimensions shown do not include those of burrs. Burr's dimensions : 0.15mm MAX.
- Residual gate : 0.3mm MAX.
- Since portion has little thickness of outer molding, the inner devices shall be appeared.

Product mass : approx. 0.1g

Plating material : SnCu (Cu : TYP. 2%)

## Date code (2 digit)

iait				
1st digit		2nd digit		
Year of production		Month of production		
Mark	Month	Mark		
0	1	1		
1	2	2		
2	3	3		
3	4	4		
4	5	5		
5	6	6		
6	7	7		
7	8	8		
8	9	9		
9	10	Х		
0	11	Y		
:	12	Z		
	oduction           Mark           0           1           2           3           4           5           6           7           8           9	oduction         Month of p           Mark         Month           0         1           1         2           2         3           3         4           4         5           5         6           6         7           7         8           8         9           9         10           0         11		

repeats in a 10 year cycle

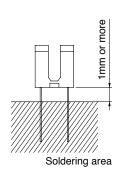
#### Rank mark

There is no rank indicator.

Country of origin Japan

#### Absolute Maximum Ratings

<b>Absolute Maximum Ratings</b> $(T_a=25^{\circ}C)$					
	Parameter	Symbol	Rating	Unit	
	Forward current	I <sub>F</sub>	50	mA	
Input	Input Reverse voltage		6	V	
	Power dissipation	Р	75	mW	
	Collector emitter veltere	V <sub>CE10</sub>	35	V	
	Collector-emitter voltage	V <sub>CE20</sub>		v	
0	Emittar collector voltage	V <sub>E1CO</sub>	6	V	
Output	Emitter-collector voltage           Collector current		0	v	
			20	mA	
Collector power dissipation		P <sub>C</sub>	75	mW	
Total power dissipation		P <sub>tot</sub>	100	mW	
Operating temperature		T <sub>opr</sub>	-25 to +85	°C	
Storage temperature		T <sub>stg</sub>	-40 to +100	°C	
*1Soldering temperature		T <sub>sol</sub>	260	°C	



\*1 For 5s or less

## Electro-optical Characteristics

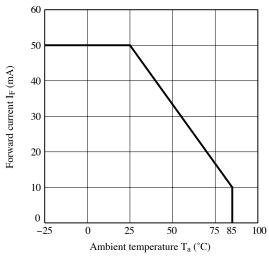
 $(T_a=25^{\circ}C)$ 

	•							-a
	Parameter		Symbol	Condition	MIN.	TYP.	MAX.	Unit
Innut	Forward voltage		$V_{\rm F}$	I <sub>F</sub> =20mA	-	1.2	1.4	V
Input	Reverse current		I <sub>R</sub>	V <sub>R</sub> =3V	_	_	10	μA
*2 Output	Collector dark current		I <sub>CEO</sub>	V <sub>CE</sub> =20V	_	_	100	nA
	Collector current		I <sub>C</sub>	V <sub>CE</sub> =5V, I <sub>F</sub> =4mA	130	-	520	μΑ
* <sup>2</sup> Transfer	Collector current ratio		$I_{C1}/I_{C2}$	$V_{CE}=5V, I_F=4mA$	0.67	_	1.5	_
charac-	Collector-emitter saturation	on voltage	V <sub>CE(sat)</sub>	$I_F=8mA$ , $I_C=50\mu A$	_	_	0.4	V
teristics	Deen on on times	Rise time	t <sub>r</sub>	V 5V I 100. A D 11-O	_	50	150	μs
_	Response time	Fall time	t <sub>f</sub>	$V_{CE}$ =5V, $I_C$ =100 $\mu$ A, $R_L$ =1 $k\Omega$	_	50	150	μs

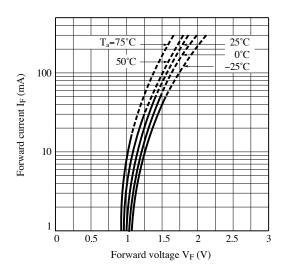
\*2 Output and Transfer characteristics are common to both phototransistors







#### Fig.3 Forward Current vs. Forward Voltage





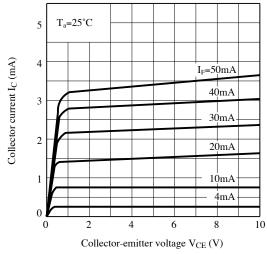
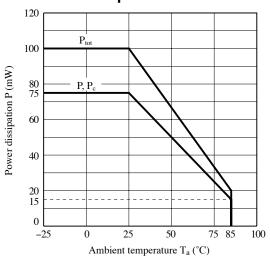
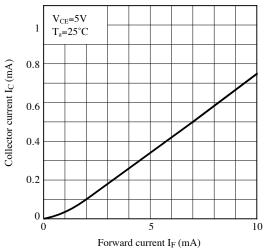


Fig.2 Power Dissipation vs. Ambient Temperature









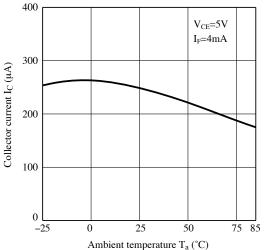
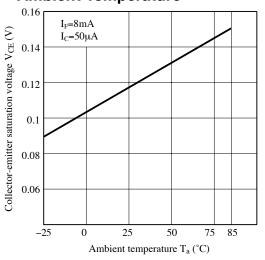
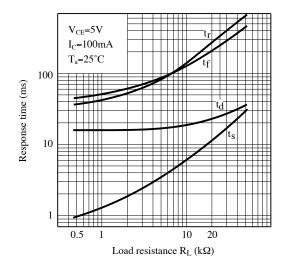


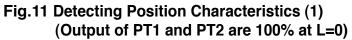


Fig.7 Collector-emitter Saturation Voltage vs. Ambient Temperature



### Fig.9 Response Time vs. Load Resistance





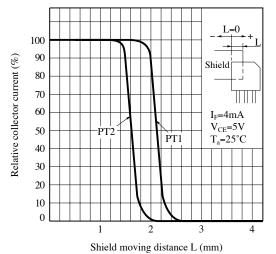
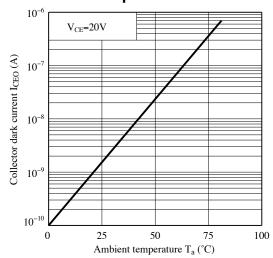
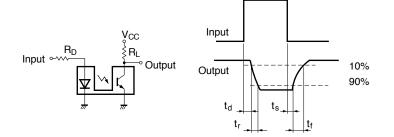


Fig.8 Collector Dark Current vs. Ambient Temperature



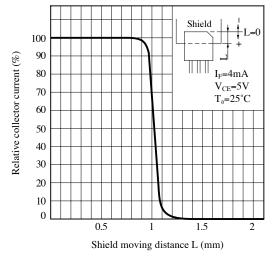
#### Fig.10 Test Circuit for Response Time



Parameter	TYP.	Unit	
PT2 detection width : L1	0.3		
PT1 detection width : L2	0.3		
Distance between detection	0.6	mm	
positions : L3	0.0		



## Fig.12 Detecting Position Characteristics (2) (Output of PT1 and PT2 are 100% at L=0)



Remarks : Please be aware that all data in the graph are just for reference and not for guarantee.



#### Design Considerations

#### Design guide

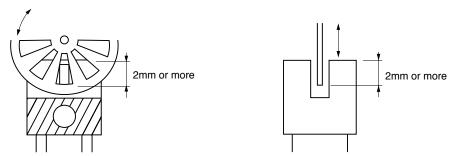
1) Prevention of detection error

To prevent photointerrupter from faulty operation caused by external light, do not set the detecting face to the external light.

2) Position of opaque board

Opaque board shall be installed at place 2mm or more from the top of elements.





This product is not designed against irradiation and incorporates non-coherent IRED.

#### Degradation

In general, the emission of the IRED used in photointerrupter will degrade over time.

In the case of long term operation, please take the general IRED degradation (50% degradation over 5 years) into the design consideration.

#### Parts

This product is assembled using the below parts.

#### • Photodetector (qty. : 2)

Category	Material	Maximum Sensitivity wavelength (nm)	Sensitivity wavelength (nm)	Response time (µs)
Phototransistor	Silicon (Si)	930	700 to 1 200	20

#### • Photo emitter (qty. : 1)

Category	Material	Maximum light emitting wavelength (nm)	I/O Frequency (MHz)
Infrared emitting diode (non-coherent)	Gallium arsenide (GaAs)	950	0.3

#### Material

Case	Lead frame	Lead frame plating
Black polyphernylene sulfide resin (UL94 V-0)	42Alloy	SnCu plating



#### Manufacturing Guidelines

#### Soldering Method

Flow Soldering:

Soldering should be completed below 260°C and within 5 s.

Please solder within one time.

Soldering area is 1mm or more away from the bottom of housing.

Please take care not to let any external force exert on lead pins.

Please don't do soldering with preheating, and please don't do soldering by reflow.

#### Hand soldering

Hand soldering should be completed within 3 s when the point of solder iron is below 350°C. Please solder within one time.

Please don't touch the terminals directly by soldering iron.

Soldered product shall treat at normal temperature.

#### Other notice

Please test the soldering method in actual condition and make sure the soldering works fine, since the impact on the junction between the device and PCB varies depending on the cooling and soldering conditions.

#### • Cleaning instructions

#### Solvent cleaning :

Solvent temperature should be 45°C or below. Immersion time should be 3 minutes or less.

Ultrasonic cleaning :

Do not execute ultrasonic cleaning.

#### Recommended solvent materials :

Ethyl alcohol, Methyl alcohol and Isopropyl alcohol.

#### Presence of ODC

This product shall not contain the following materials. And they are not used in the production process for this product. Regulation substances : CFCs, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methylchloroform)

Specific brominated flame retardants such as the PBBOs and PBBs are not used in this product at all.

This product shall not contain the following materials banned in the RoHS Directive (2002/95/EC).
Lead, Mercury, Cadmium, Hexavalent chromium, Polybrominated biphenyls (PBB), Polybrominated diphenyl ethers (PBDE).



#### ■ Package specification

#### Sleeve package

Package materials Sleeve : Polystyrene Stopper : Styrene-butadiene

Package method

MAX. 40 pcs. of products shall be packaged in a sleeve. Both ends shall be closed by tabbed and tabless stoppers.

MAX. 50 sleeves in one case.

#### Important Notices

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- --- Office automation equipment
- --- Telecommunication equipment [terminal]
- --- Test and measurement equipment
- --- Industrial control
- --- Audio visual equipment
- --- Consumer electronics

(ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection with equipment that requires higher reliability such as:

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- --- Traffic signals
- --- Gas leakage sensor breakers
- --- Alarm equipment
- --- Various safety devices, etc.

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- --- Telecommunication equipment [trunk lines]
- --- Nuclear power control equipment
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